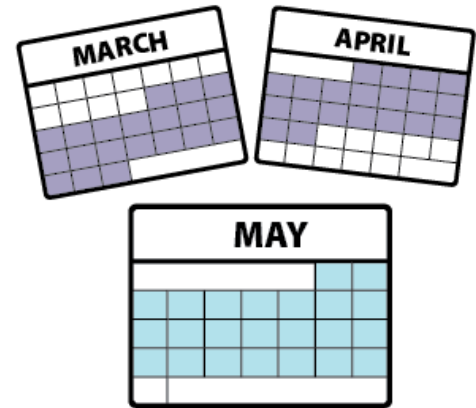


Consolidate Testing Into One Window

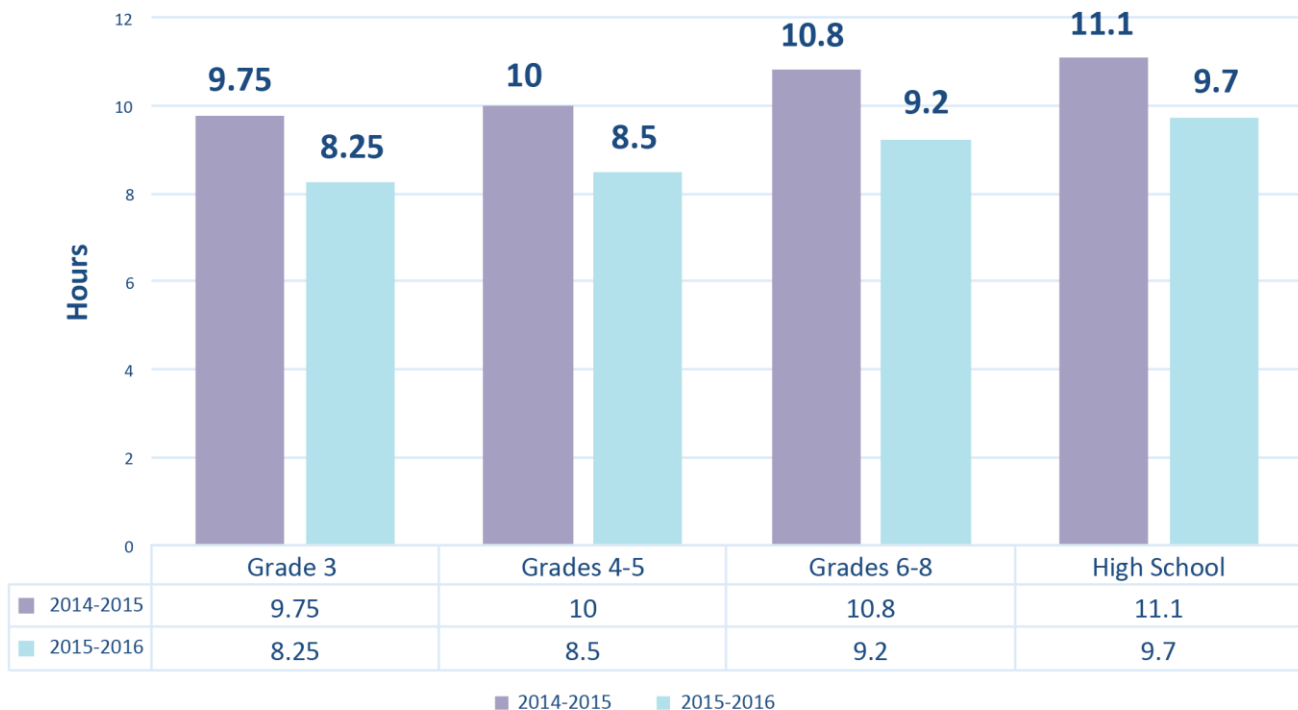
The PARCC assessments are changing! In 2015-16, the assessment will be given during one window. States and schools will have up to 30 school days in which to test, but most can/will complete all testing in a week to two weeks, depending on their schedule and availability of laptops/devices.

The new single window will end at the 90% mark of the school year. Gone are the separate early spring performance-based (PBA) and late spring end-of-year (EOY) windows.



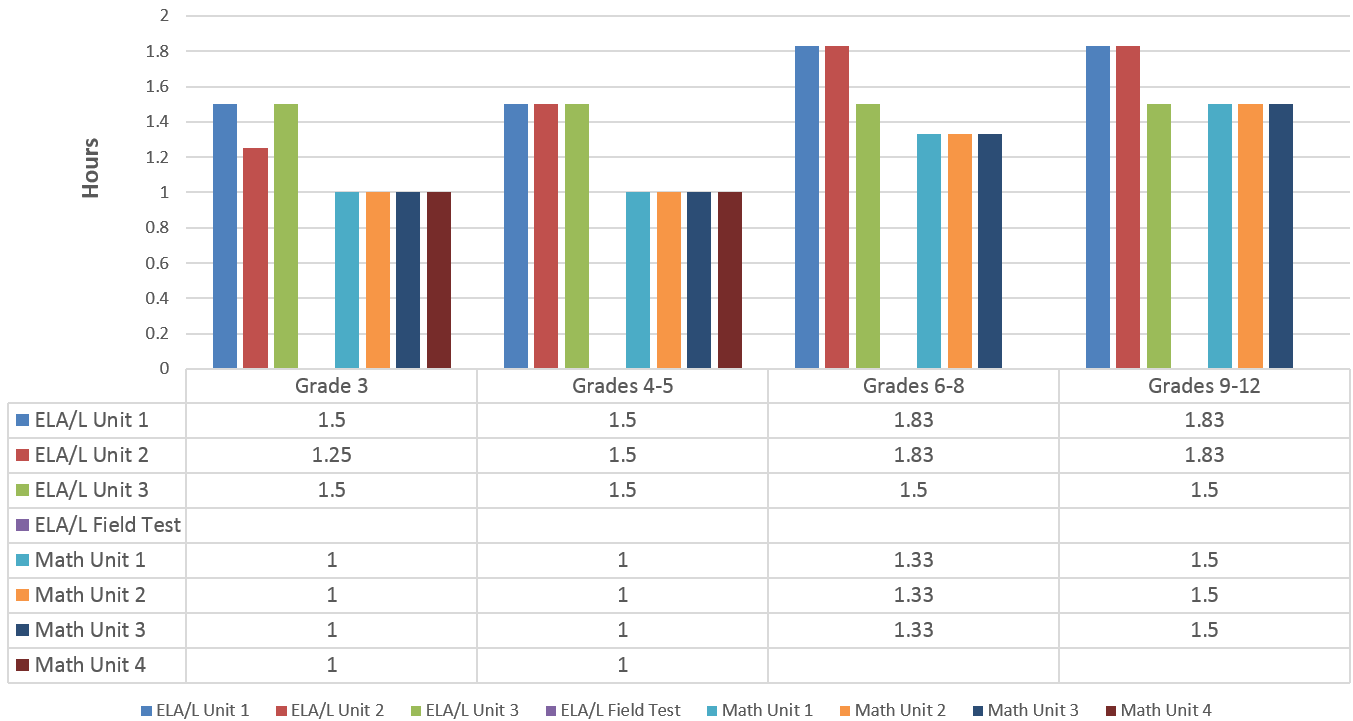
Cuts Testing Time by approximately 90 minutes in all grades

Total Testing Time: 2014-15 v. 2015-16



Uniformity of Testing Units

More Uniform Test Unit Times



Reduces the Number of Test Units

With the changes, students in all grades will participate in fewer test units.

Each PARCC assessment, e.g., grade 4 math, is administered in multiple sections called units. The redesigned ELA/L tests are composed of 3 units. The proposed math tests are composed of 3 or 4 units.

	2014-2015			2015-2016		
Grades	ELA	Math	Total	ELA	Math	Total
3	4	4	8	3	4	7
4-5	4	4	8	3	4	7
6-8	5	4	9	3	3	6
High School	5	4	9	3	3	6

Preserves Performance Tasks

The test design changes do not result in the loss of any performance tasks in English language arts/literacy or mathematics with the exception of Algebra II and Integrated Math III at the high school level.

Eliminates Standalone Field Testing

As with all similar testing, field test items – items that could be used in future years – are embedded in each student’s test. Because the performance tasks in English language arts/literacy are longer, a sampling of students had to take a standalone field test unit in spring 2015. To further streamline the process for all schools, the PARCC field test will now be wrapped into the testing window.

Each year, a small percentage of students will take an additional ELA unit. Schools/classrooms selected in one year – per the process determined in their state – will in almost all cases not have to field test again for several years.